

# NM27C010

## 1,048,576-Bit (128K x 8) High Performance CMOS EPROM

### General Description

The NM27C010 is a high performance, 1,048,576-bit Electrically Programmable UV Erasable Read Only Memory. It is organized as 128K-words of 8 bits each. Its pin-compatibility with byte-wide JEDEC EPROMs enables upgrades through 8 Mbit EPROMs. The "Don't Care" feature during read operations allows memory expansions from 1M to 8M bits with no printed circuit board changes.

The NM27C010 can directly replace lower density 28-pin EPROMs by adding an A16 address line and V<sub>CC</sub> jumper. During the normal read operation PGM and V<sub>PP</sub> are in a "Don't Care" state which allows higher order addresses, such as A17, A18, and A19 to be connected without affecting the normal read operation. This allows memory upgrades to 8M bits without hardware changes. The NM27C010 is also offered in a 32-pin plastic DIP with the same upgrade path.

The NM27C010 provides microprocessor-based systems extensive storage capacity for large portions of operating system and application software. Its 90 ns access time provides no-wait-state operation with high-performance CPUs. The NM27C010 offers a single chip solution for the code storage requirements of 100% firmware-based equipment. Frequently-used software routines are quickly executed from EPROM storage, greatly enhancing system utility.

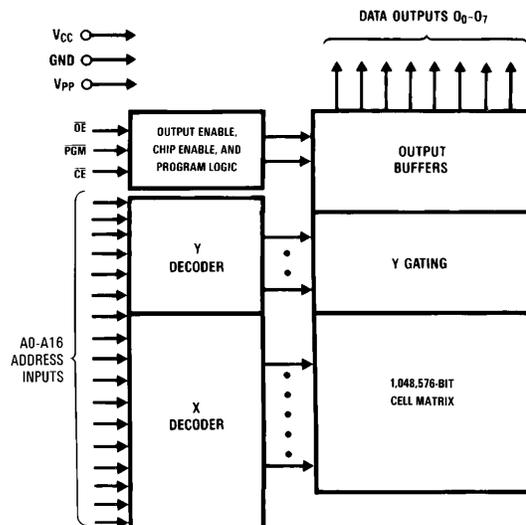
The NM27C010 is manufactured using National's advanced CMOS AMG™ EPROM technology.

The NM27C010 is one member of a high density EPROM Family which range in densities up to 4 Megabit.

### Features

- High performance CMOS
  - 90 ns access time
- Fast turn-off for microprocessor compatibility
- Simplified upgrade path
  - V<sub>PP</sub> and PGM are "Don't Care" during normal read operation
- Manufacturers identification code
- Fast programming
- JEDEC standard pin configurations
  - 32-pin DIP package
  - 32-pin PLCC package
  - 32-pin TSOP package

### Block Diagram



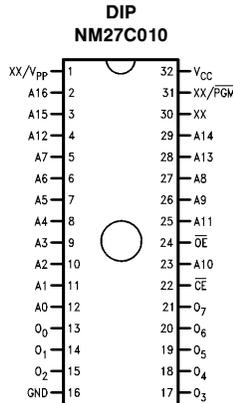
TL/D/10798-1

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# Connection Diagrams

## DIP PIN CONFIGURATIONS

27C080	27C040	27C020	27C512	27C256
A19	XX/V <sub>PP</sub>	XX/V <sub>PP</sub>		
A16	A16	A16		
A15	A15	A15	A15	V <sub>PP</sub>
A12	A12	A12	A12	A12
A7	A7	A7	A7	A7
A6	A6	A6	A6	A6
A5	A5	A5	A5	A5
A4	A4	A4	A4	A4
A3	A3	A3	A3	A3
A2	A2	A2	A2	A2
A1	A1	A1	A1	A1
A0	A0	A0	A0	A0
O <sub>0</sub>	O <sub>0</sub>	O <sub>0</sub>	O <sub>0</sub>	O <sub>0</sub>
O <sub>1</sub>	O <sub>1</sub>	O <sub>1</sub>	O <sub>1</sub>	O <sub>1</sub>
O <sub>2</sub>	O <sub>2</sub>	O <sub>2</sub>	O <sub>2</sub>	O <sub>2</sub>
GND	GND	GND	GND	GND



27C256	27C512	27C020	27C040	27C080
		V <sub>CC</sub>	V <sub>CC</sub>	V <sub>CC</sub>
		XX/PGM	A18	A18
V <sub>CC</sub>	V <sub>CC</sub>	A17	A17	A17
A14	A14	A14	A14	A14
A13	A13	A13	A13	A13
A8	A8	A8	A8	A8
A9	A9	A9	A9	A9
A11	A11	A11	A11	A11
OE	OE/V <sub>PP</sub>	OE	OE	OE/V <sub>PP</sub>
A10	A10	A10	A10	A10
CE/PGM	CE/PGM	CE	CE/PGM	CE/PGM
O <sub>7</sub>	O <sub>7</sub>	O <sub>7</sub>	O <sub>7</sub>	O <sub>7</sub>
O <sub>6</sub>	O <sub>6</sub>	O <sub>6</sub>	O <sub>6</sub>	O <sub>6</sub>
O <sub>5</sub>	O <sub>5</sub>	O <sub>5</sub>	O <sub>5</sub>	O <sub>5</sub>
O <sub>4</sub>	O <sub>4</sub>	O <sub>4</sub>	O <sub>4</sub>	O <sub>4</sub>
O <sub>3</sub>	O <sub>3</sub>	O <sub>3</sub>	O <sub>3</sub>	O <sub>3</sub>

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Note: Compatible EPROM pin configurations are shown in the blocks adjacent to the NM27C010 pins.

### Commercial Temperature Range (0°C to +70°C) V<sub>CC</sub> = 5V ± 10%

Parameter/Order Number	Access Time (ns)
NM27C010 Q, V, N, T 90	90
NM27C010 Q, V, N, T 120	120
NM27C010 Q, V, N, T 150	150
NM27C010 Q, V, N, T 200	200

### Military Temperature Range (-55°C to +125°C) V<sub>CC</sub> = 5V ± 10%

Parameter/Order Number	Access Time (ns)
NM27C010 QM 150	150
NM27C010 QM 200	200

Note: Surface mount PLCC package available for commercial and extended temperature ranges only.

Package Types: NM27C010 Q, N, V XXX

Q = Quartz-Windowed Ceramic DIP package

V = PLCC package

N = Plastic DIP package

T = TSOP package

- All packages conform to JEDEC standard.
- All versions are guaranteed to function at slower speeds.

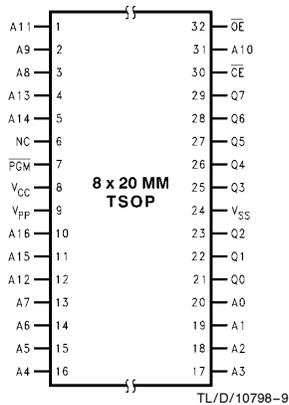
### Extended Temperature Range (-40°C to +85°C) V<sub>CC</sub> = 5V ± 10%

Parameter/Order Number	Access Time (ns)
NM27C010 QE, VE, NE 100	100
NM27C010 QE, VE, NE 120	120
NM27C010 QE, VE, NE 150	150
NM27C010 QE, VE, NE 200	200

### Pin Names

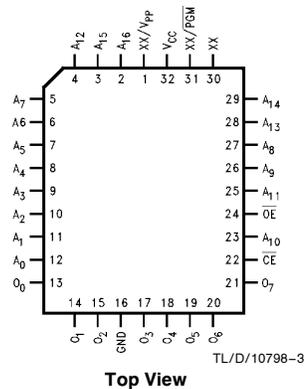
A0–A16	Addresses
CE	Chip Enable
OE	Output Enable
O0–O7	Outputs
PGM	Program
XX	Don't Care (During Read)

### TSOP Pin Configuration



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### PLCC Pin Configuration



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## Absolute Maximum Ratings (Note 1)

If Military/Aerospace specified devices are required, please contact the National Semiconductor Sales Office/Distributors for availability and specifications.

Storage Temperature  $-65^{\circ}\text{C}$  to  $+150^{\circ}\text{C}$

All Input Voltages Except  $A_9$  with Respect to Ground (Note 10)  $-0.6\text{V}$  to  $+7\text{V}$

$V_{PP}$  and  $A_9$  with Respect to Ground  $-0.6\text{V}$  to  $+14\text{V}$

$V_{CC}$  Supply Voltage with Respect to Ground  $-0.6\text{V}$  to  $+7\text{V}$

ESD Protection  $>2000\text{V}$

All Output Voltages with Respect to Ground (Note 10)  $V_{CC} + 1.0\text{V}$  to  $\text{GND} - 0.6\text{V}$

## Operating Range

Range	Temperature	$V_{CC}$	Tolerance
Commercial	$0^{\circ}\text{C}$ to $+70^{\circ}\text{C}$	+5V	$\pm 10\%$
Industrial	$-40^{\circ}\text{C}$ to $+85^{\circ}\text{C}$	+5V	$\pm 10\%$
Military	$-55^{\circ}\text{C}$ to $+125^{\circ}\text{C}$	+5V	$\pm 10\%$

## DC Read Characteristics Over Operating Range with $V_{PP} = V_{CC}$

Symbol	Parameter	Test Conditions	Min	Max	Units
$V_{IL}$	Input Low Level		-0.5	0.8	V
$V_{IH}$	Input High Level		2.0	$V_{CC} + 1$	V
$V_{OL}$	Output Low Voltage	$I_{OL} = 2.1\text{ mA}$		0.4	V
$V_{OH}$	Output High Voltage	$I_{OH} = -2.5\text{ mA}$	3.5		V
$I_{SB1}$	$V_{CC}$ Standby Current (CMOS)	$\overline{CE} = V_{CC} \pm 0.3\text{V}$		100	$\mu\text{A}$
$I_{SB2}$	$V_{CC}$ Standby Current (TTL)	$\overline{CE} = V_{IH}$		1	mA
$I_{CC}$	$V_{CC}$ Active Current	$\overline{CE} = \overline{OE} = V_{IL}$ $I/O = 0\text{ mA}$	$f = 5\text{ MHz}$	30	mA
$I_{PP}$	$V_{PP}$ Supply Current	$V_{PP} = V_{CC}$		10	$\mu\text{A}$
$V_{PP}$	$V_{PP}$ Read Voltage		$V_{CC} - 0.7$	$V_{CC}$	V
$I_{LI}$	Input Load Current	$V_{IN} = 5.5$ or $\text{GND}$	-1	1	$\mu\text{A}$
$I_{LO}$	Output Leakage Current	$V_{OUT} = 5.5\text{V}$ or $\text{GND}$	-10	10	$\mu\text{A}$

## AC Read Characteristics Over Operating Range with $V_{PP} = V_{CC}$

Symbol	Parameter	90		120		150		200		Units
		Min	Max	Min	Max	Min	Max	Min	Max	
$t_{ACC}$	Address to Output Delay		90		120		150		200	ns
$t_{CE}$	$\overline{CE}$ to Output Delay		90		120		150		200	
$t_{OE}$	$\overline{OE}$ to Output Delay		40		50		50		50	
$t_{DF}$ (Note 2)	Output Disable to Output Float		35		35		45		55	
$t_{OH}$ (Note 2)	Output Hold from Addresses, $\overline{CE}$ or $\overline{OE}$ , Whichever Occurred First	0		0		0		0		

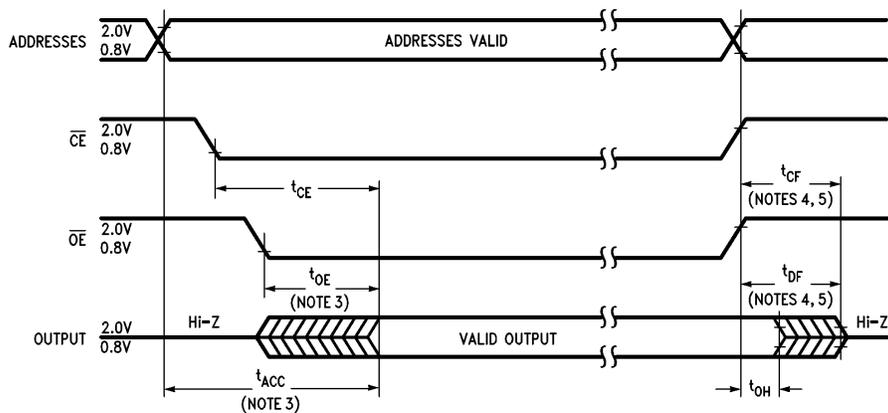
## Capacitance $T_A = +25^\circ\text{C}$ , $f = 1\text{ MHz}$ (Note 2)

Symbol	Parameter	Conditions	Typ	Max	Units
$C_{IN}$	Input Capacitance	$V_{IN} = 0\text{V}$	6	15	pF
$C_{OUT}$	Output Capacitance	$V_{OUT} = 0\text{V}$	10	15	pF

## AC Test Conditions

Output Load	1 TTL Gate and $C_L = 100\text{ pF}$ (Note 8)	Timing Measurement Reference Level Inputs Outputs	0.8V and 2V 0.8V and 2V
Input Rise and Fall Times	$\leq 5\text{ ns}$		
Input Pulse Levels	0.45V to 2.4V		

## AC Waveforms (Notes 6, 7, & 9)



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**Note 1:** Stresses above those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

**Note 2:** This parameter is only sampled and is not 100% tested.

**Note 3:**  $\overline{OE}$  may be delayed up to  $t_{ACC} - t_{OE}$  after the falling edge of  $\overline{CE}$  without impacting  $t_{ACC}$ .

**Note 4:** The  $t_{DF}$  and  $t_{CF}$  compare level is determined as follows:

High to TRI-STATE<sup>®</sup>, the measured  $V_{OH1}$  (DC) - 0.10V;

Low to TRI-STATE, the measured  $V_{OL1}$  (DC) + 0.10V.

**Note 5:** TRI-STATE may be attained using  $\overline{OE}$  or  $\overline{CE}$ .

**Note 6:** The power switching characteristics of EPROMs require careful device decoupling. It is recommended that at least a 0.1  $\mu\text{F}$  ceramic capacitor be used on every device between  $V_{CC}$  and GND.

**Note 7:** The outputs must be restricted to  $V_{CC} + 1.0\text{V}$  to avoid latch-up and device damage.

**Note 8:** 1 TTL Gate:  $I_{OL} = 1.6\text{ mA}$ ,  $I_{OH} = -400\text{ }\mu\text{A}$ .

$C_L$ : 100 pF includes fixture capacitance.

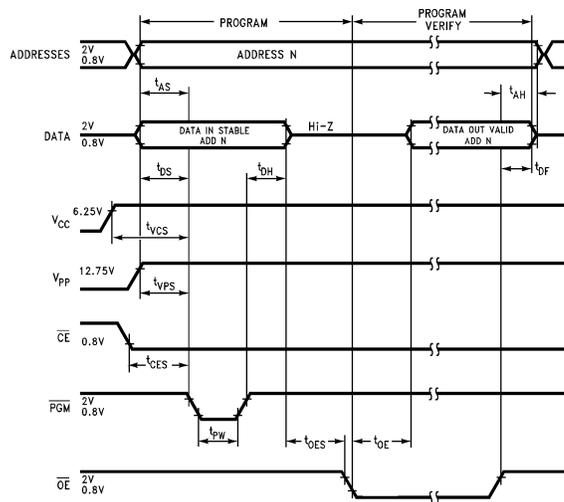
**Note 9:**  $V_{PP}$  may be connected to  $V_{CC}$  except during programming.

**Note 10:** Inputs and outputs can undershoot to  $-2.0\text{V}$  for 20 ns Max.

## Programming Characteristics (Notes 1, 2, 3, 4, & 5)

Symbol	Parameter	Conditions	Min	Typ	Max	Units
$t_{AS}$	Address Setup Time		1			$\mu\text{s}$
$t_{OES}$	$\overline{OE}$ Setup Time		1			$\mu\text{s}$
$t_{CES}$	$\overline{CE}$ Setup Time	$\overline{OE} = V_{IH}$	1			$\mu\text{s}$
$t_{DS}$	Data Setup Time		1			$\mu\text{s}$
$t_{VPS}$	$V_{PP}$ Setup Time		1			$\mu\text{s}$
$t_{VCS}$	$V_{CC}$ Setup Time		1			$\mu\text{s}$
$t_{AH}$	Address Hold Time		0			$\mu\text{s}$
$t_{DH}$	Data Hold Time		1			$\mu\text{s}$
$t_{DF}$	Output Enable to Output Float Delay	$\overline{CE} = V_{IL}$	0		60	ns
$t_{PW}$	Program Pulse Width		95	100	105	$\mu\text{s}$
$t_{OE}$	Data Valid from $\overline{OE}$	$\overline{CE} = V_{IL}$			100	$\mu\text{s}$
$I_{PP}$	$V_{PP}$ Supply Current during Programming Pulse	$\overline{CE} = V_{IL}$ $\overline{PGM} = V_{IL}$			15	mA
$I_{CC}$	$V_{CC}$ Supply Current				20	mA
$T_A$	Temperature Ambient		20	25	30	$^{\circ}\text{C}$
$V_{CC}$	Power Supply Voltage		6.0	6.25	6.5	V
$V_{PP}$	Programming Supply Voltage		12.5	12.75	13.0	V
$t_{FR}$	Input Rise, Fall Time		5			ns
$V_{IL}$	Input Low Voltage			0.0	0.45	V
$V_{IH}$	Input High Voltage		2.4	4.0		V
$t_{IN}$	Input Timing Reference Voltage		0.8		2.0	V
$t_{OUT}$	Output Timing Reference Voltage		0.8		2.0	V

## Programming Waveforms (Note 3)



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**Note 1:** National's standard product warranty applies only to devices programmed to specifications described herein.

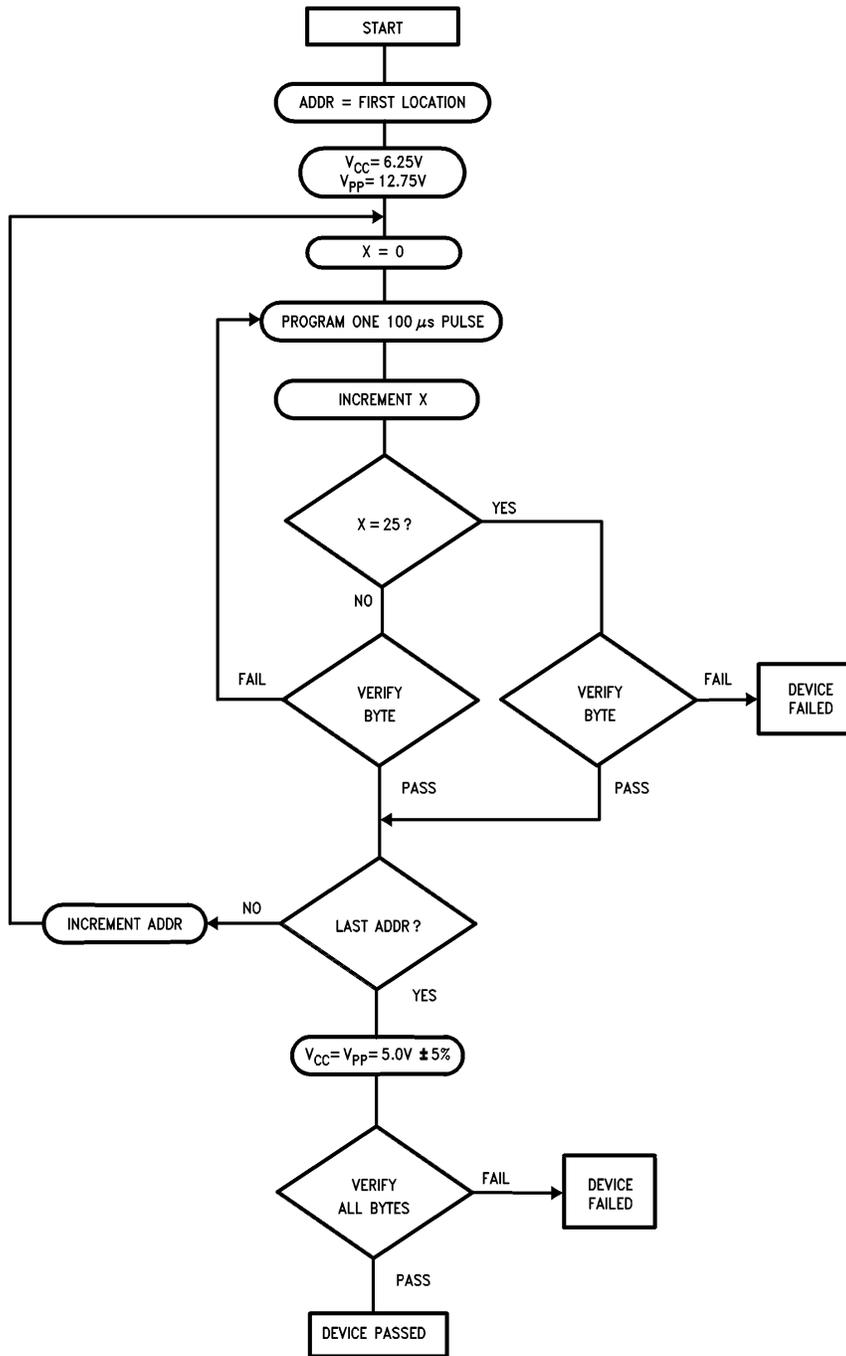
**Note 2:**  $V_{CC}$  must be applied simultaneously or before  $V_{PP}$  and removed simultaneously or after  $V_{PP}$ . The EPROM must not be inserted into or removed from a board with voltage applied to  $V_{PP}$  or  $V_{CC}$ .

**Note 3:** The maximum absolute allowable voltage which may be applied to the  $V_{PP}$  pin during programming is 14V. Care must be taken when switching the  $V_{PP}$  supply to prevent any overshoot from exceeding this 14V maximum specification. At least a 0.1  $\mu\text{F}$  capacitor is required across  $V_{PP}$ ,  $V_{CC}$  to GND to suppress spurious voltage transients which may damage the device.

**Note 4:** Programming and program verify are tested with the fast Program Algorithm, at typical power supply voltages and timings.

**Note 5:** During power up the  $\overline{PGM}$  pin must be brought high ( $\geq V_{IH}$ ) either coincident with or before power is applied to  $V_{PP}$ .

**Fast Programming Algorithm Flow Chart** (Same as NMC27C010)



**FIGURE 1**

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## Functional Description

### DEVICE OPERATION

The six modes of operation of the EPROM are listed in Table I. It should be noted that all inputs for the six modes are at TTL levels. The power supplies required are  $V_{CC}$  and  $V_{PP}$ . The  $V_{PP}$  power supply must be at 12.75V during the three programming modes, and must be at 5V in the other three modes. The  $V_{CC}$  power supply must be at 6.25V during the three programming modes, and at 5V in the other three modes.

#### Read Mode

The EPROM has two control functions, both of which must be logically active in order to obtain data at the outputs. Chip Enable ( $\overline{CE}$ ) is the power control and should be used for device selection. Output Enable ( $\overline{OE}$ ) is the output control and should be used to gate data to the output pins, independent of device selection. Assuming that the addresses are stable, address access time ( $t_{ACC}$ ) is equal to the delay from  $\overline{CE}$  to output ( $t_{CE}$ ). Data is available at the outputs  $t_{OE}$  after the falling edge of  $\overline{OE}$ , assuming that  $\overline{CE}$  has been low and addresses have been stable for at least  $t_{ACC}-t_{OE}$ .

#### Standby Mode

The EPROM has a standby mode which reduces the active power dissipation by over 99%, from 165 mW to 0.55 mW. The EPROM is placed in the standby mode by applying a CMOS high signal to the  $\overline{CE}$  input. When in standby mode, the outputs are in a high impedance state, independent of the  $\overline{OE}$  input.

#### Output Disable

The EPROM is placed in output disable by applying a TTL high signal to the OE input. When in output disable all circuitry is enabled, except the outputs are in a high impedance state (TRI-STATE).

#### Output OR-Tying

Because the EPROM is usually used in larger memory arrays, National has provided a 2-line control function that accommodates this use of multiple memory connections. The 2-line control function allows for:

- a) the lowest possible memory power dissipation, and
- b) complete assurance that output bus contention will not occur.

To most efficiently use these two control lines, it is recommended that CE be decoded and used as the primary device selecting function, while OE be made a common connection to all devices in the array and connected to the READ line from the system control bus. This assures that all deselected memory devices are in their low power standby modes and that the output pins are active only when data is desired from a particular memory device.

#### Programming

CAUTION: Exceeding 14V on the  $V_{PP}$  or A9 pin will damage the EPROM.

Initially, and after each erasure, all bits of the EPROM are in the "1's" state. Data is introduced by selectively programming "0's" into the desired bit locations. Although only "0's" will be programmed, both "1's" and "0's" can be presented in the data word. The only way to change a "0" to a "1" is by ultraviolet light erasure.

The EPROM is in the programming mode when the  $V_{PP}$  power supply is at 12.75V and  $\overline{OE}$  is at  $V_{IH}$ . It is required that at least a 0.1  $\mu$ F capacitor be placed across  $V_{PP}$ ,  $V_{CC}$  to ground to suppress spurious voltage transients which may damage the device. The data to be programmed is applied 8 bits in parallel to the data output pins. The levels required for the address and data inputs are TTL.

When the address and data are stable, an active low, TTL program pulse is applied to the  $\overline{PGM}$  input. A program pulse must be applied at each address location to be programmed. The EPROM is programmed with the Fast Programming Algorithm shown in Figure 1. Each Address is programmed with a series of 100  $\mu$ s pulses until it verifies good, up to a maximum of 25 pulses. Most memory cells will program with a single 100  $\mu$ s pulse.

The EPROM must not be programmed with a DC signal applied to the  $\overline{PGM}$  input.

Programming multiple EPROM in parallel with the same data can be easily accomplished due to the simplicity of the programming requirements. Like inputs of the parallel EPROM may be connected together when they are programmed with the same data. A low level TTL pulse applied to the  $\overline{PGM}$  input programs the paralleled EPROM.

#### Program Inhibit

Programming multiple EPROM's in parallel with different data is also easily accomplished. Except for  $\overline{CE}$  all like inputs (including  $\overline{OE}$  and  $\overline{PGM}$ ) of the parallel EPROM may be common. A TTL low level program pulse applied to an EPROM's  $\overline{PGM}$  input with  $\overline{CE}$  at  $V_{IL}$  and  $V_{PP}$  at 12.75V will program that EPROM. A TTL high level  $\overline{CE}$  input inhibits the other EPROM's from being programmed.

#### Program Verify

A verify should be performed on the programmed bits to determine whether they were correctly programmed. The verify may be performed with  $V_{PP}$  at 12.75V.  $V_{PP}$  must be at  $V_{CC}$ , except during programming and program verify.

#### AFTER PROGRAMMING

Opaque labels should be placed over the EPROM window to prevent unintentional erasure. Covering the window will also prevent temporary functional failure due to the generation of photo currents.

#### MANUFACTURER'S IDENTIFICATION CODE

The EPROM has a manufacturer's identification code to aid in programming. When the device is inserted in an EPROM programmer socket, the programmer reads the code and then automatically calls up the specific programming algorithm for the part. This automatic programming control is only possible with programmers which have the capability of reading the code.

The Manufacturer's Identification code, shown in Table II, specifically identifies the manufacturer and device type. The code for the NM27C010 is "8F86", where "8F" designates that it is made by National Semiconductor, and "86" designates a 1 Megabit (128K  $\times$  8) part.

The code is accessed by applying 12V  $\pm$  0.5V to address pin A9. Addresses A1-A8, A10-A16, and all control pins are held at  $V_{IL}$ . Address pin A0 is held at  $V_{IL}$  for the manufacturer's code, and held at  $V_{IH}$  for the device code. The code is read on the eight data pins, O0-O7. Proper code access is only guaranteed at 25°C  $\pm$  5°C.

## Functional Description (Continued)

### ERASURE CHARACTERISTICS

The erasure characteristics of the device are such that erasure begins to occur when exposed to light with wavelengths shorter than approximately 4000 Angstroms (Å). It should be noted that sunlight and certain types of fluorescent lamps have wavelengths in the 3000Å–4000Å range.

The recommended erasure procedure for the EPROM is exposure to short wave ultraviolet light which has a wavelength of 2537Å. The integrated dose (i.e., UV intensity X exposure time) for erasure should be a minimum of 15W-sec/cm<sup>2</sup>.

The EPROM should be placed within 1 inch of the lamp tubes during erasure. Some lamps have a filter on their tubes which should be removed before erasure.

An erasure system should be calibrated periodically. The distance from lamp to device should be maintained at one inch. The erasure time increases as the square of the distance from the lamp. (if distance is doubled the erasure time increases by factor of 4). Lamps lose intensity as they age. When a lamp is changed, the distance has changed, or the lamp has aged, the system should be checked to make certain full erasure is occurring. Incomplete erasure will cause

symptoms that can be misleading. Programmers, components and even system designs have been erroneously suspected when incomplete erasure was the problem.

### SYSTEM CONSIDERATION

The power switching characteristics of EPROMs require careful decoupling of the devices. The supply current, I<sub>CC</sub>, has three segments that are of interest to the system designer: the standby current level, the active current level, and the transient current peaks that are produced by voltage transitions on input pins. The magnitude of these transient current peaks is dependent on the output capacitance loading of the device. The associated V<sub>CC</sub> transient voltage peaks can be suppressed by properly selected decoupling capacitors. It is recommended that at least a 0.1 μF ceramic capacitor be used on every device between V<sub>CC</sub> and GND. This should be a high frequency capacitor of low inherent inductance. In addition, at least a 4.7 μF electrolytic capacitor should be used between V<sub>CC</sub> and GND for each eight devices. The bulk capacitor should be located near where the power supply is connected to the array. The purpose of the bulk capacitor is to overcome the voltage drop caused by the inductive effects of the PC board traces.

### MODE SELECTION

The modes of operation of the NM27C010 are listed in Table I. A single 5V power supply is required in the read mode. All inputs are TTL levels except for V<sub>PP</sub> and A9 for device signature.

TABLE I. Modes Selection

Pins	$\overline{CE}$	$\overline{OE}$	$\overline{PGM}$	V <sub>PP</sub>	V <sub>CC</sub>	Outputs
Mode						
Read	V <sub>IL</sub>	V <sub>IL</sub>	X (Note 1)	X	5.0V	D <sub>OUT</sub>
Output Disable	X	V <sub>IH</sub>	X	X	5.0V	High Z
Standby	V <sub>IH</sub>	X	X	X	5.0V	High Z
Programming	V <sub>IL</sub>	V <sub>IH</sub>	V <sub>IL</sub>	12.75V	6.25V	D <sub>IN</sub>
Program Verify	V <sub>IL</sub>	V <sub>IL</sub>	V <sub>IH</sub>	12.75V	6.25V	D <sub>OUT</sub>
Program Inhibit	V <sub>IH</sub>	X	X	12.75V	6.25V	High Z

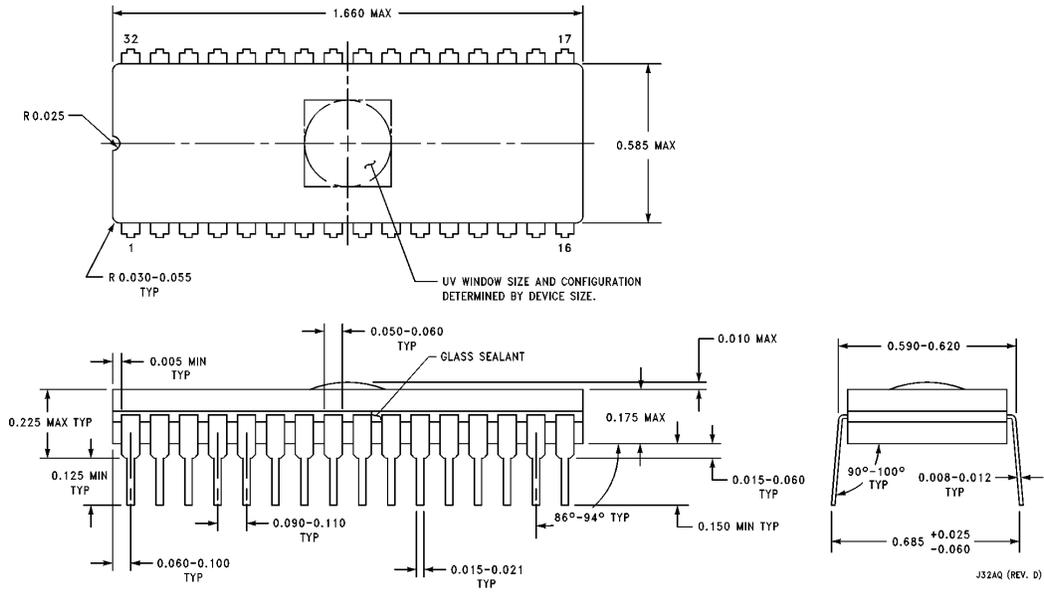
Note 1: X can be V<sub>IL</sub> or V<sub>IH</sub>.

TABLE II. Manufacturer's Identification Code

Pins	A0 (12)	A9 (26)	O7 (21)	O6 (20)	O5 (19)	O4 (18)	O3 (17)	O2 (15)	O1 (14)	O0 (13)	Hex Data
Manufacturer Code	V <sub>IL</sub>	12V	1	0	0	0	1	1	1	1	8F
Device Code	V <sub>IH</sub>	12V	1	0	0	0	0	1	1	0	86



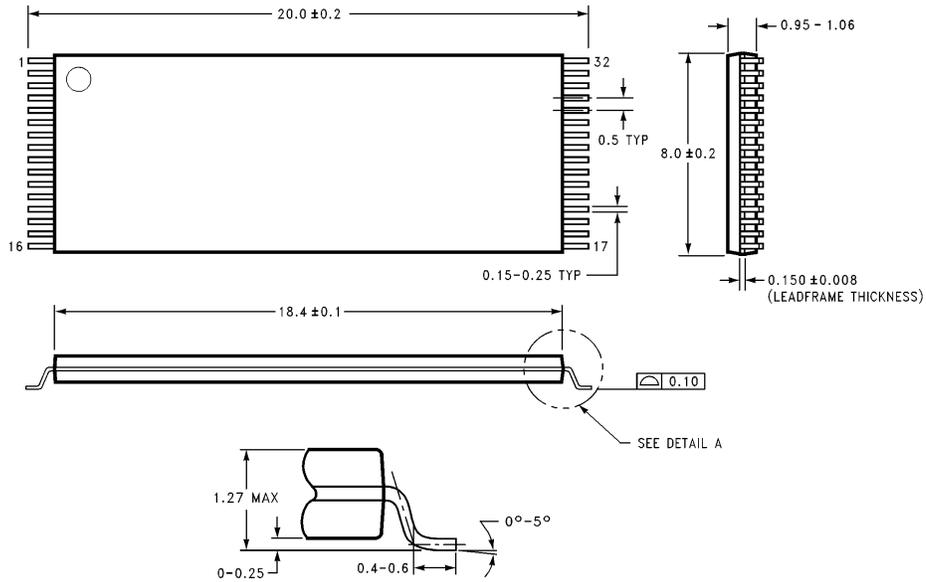
**Physical Dimensions** inches (millimeters)



**32-Lead EPROM Ceramic Dual-In-Line Package (Q)**  
**Order Number NM27C010QXXX**  
**NS Package Number J32AQ**

J32AQ (REV. D)

**Physical Dimensions** millimeters (Continued)



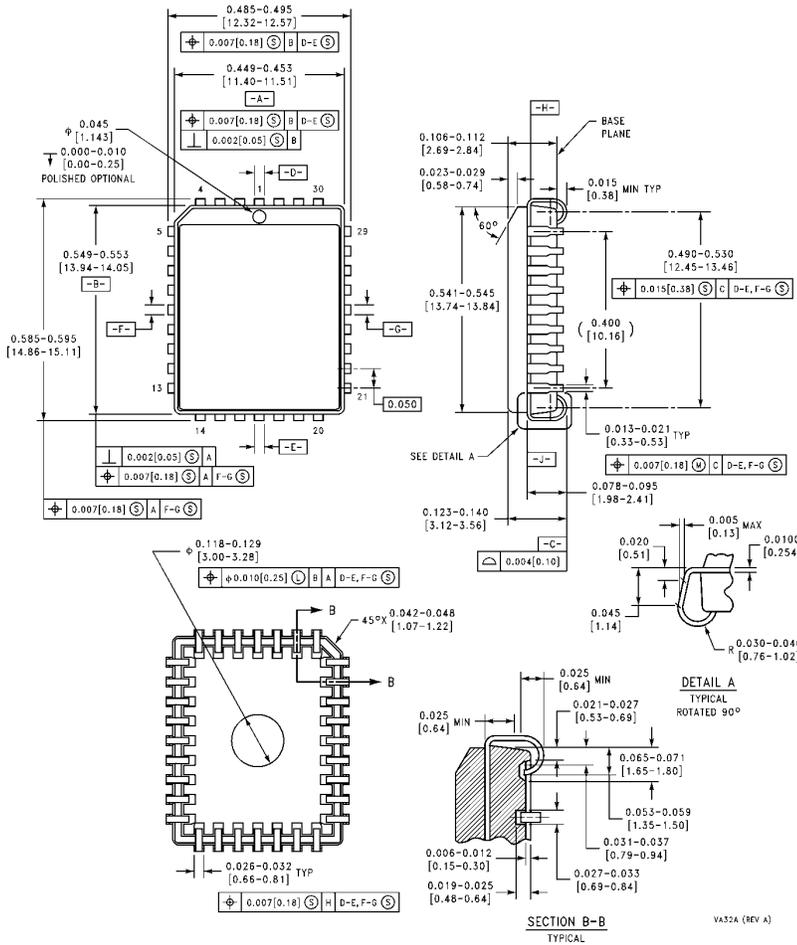
**DETAIL A**

TYPICAL

**32-Lead TSOP, EIAJ Type I (T)**  
**Order Number NM27C010TXXX**  
**NS Package Number MBH32A**

MBH32A (REV B)

**Physical Dimensions** inches (millimeters) (Continued)



**32-Lead PLCC Package**  
**Order Number NM27C010VXX**  
**NS Package Number VA32A**

**LIFE SUPPORT POLICY**

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2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

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